


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510516	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA ET AL.
	<b>Examiner</b>  AMEE A SHAH	<b>Art Unit</b>  3625

SEARCHED			
Class	Subclass	Date	Examiner
705	1.1, 26, 27	8/10/2010	AAS
351	205	8/10/2010	AAS
422	37	8/10/2010	AAS

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search incl fwd/bkwd citation searches on closest prior art	8/10/2010	AAS
PALM inventor search incl review of related files	8/9/2010	AAS
NPL search - Dialog	8/10/2010	AAS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
705	1.1	8/10/2010	AAS
351	205	8/10/2010	AAS

	/AMEE A SHAH/ Primary Examiner.Art Unit 3625
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